

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/779,750	TAKADA ET AL.
	Examiner	Art Unit
	Yonel Beaulieu	3661

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
701	21	12/24/2005	YB
	41		
180	6.2		